

Notice of References Cited	Application/Control No. 10/774,883		Applicant(s)/Patent Under Reexamination FUNG ET AL.	
	Examiner Phallaka Kik		Art Unit 2825	Page 1 of 3

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,659,484	08-1997	Bennett et al.	716/16
*	B	US-5,521,837	05-1996	Frankle et al.	716/10
*	C	US-5,541,849	07-1996	Rostoker et al.	716/18
*	D	US-5,237,514	08-1993	Curtin, James J.	716/10
*	E	US-6,763,506	07-2004	Betz et al.	716/6
*	F	US-2005/0251775	11-2005	Wood, John	716/010
*	G	US-2005/0138578	06-2005	Alpert et al.	716/002
*	H	US-2005/0132318	06-2005	Kidd et al.	716/012
*	I	US-2005/0039156	02-2005	Catthoor et al.	716/018
*	J	US-2004/0243964	12-2004	McElvain et al.	716/012
*	K	US-2003/0005398	01-2003	Cho et al.	716/8
*	L	US-6,826,733	11-2004	Hathaway et al.	716/2
*	M	US-6,708,139	03-2004	Rearick et al.	702/185

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	NN9107410, "Linear Algorithm for Distributing Slack So That All Nets of A Design Have a Zero Slack Pin", IBM Technical Disclosure Bulletin, Vol. 34, No. 2, July 1991, pp. 410-414 (7 pages).
	V	Mathur et al., "Timing-Driven Placement for Regular Architectures", IEEE Transactions on Computer-Aided Design of Integrated Circuits and Systems, Vol. 16, No. 6, June 1997, pp. 597-608.
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited	Application/Control No. 10/774,883	Applicant(s)/Patent Under Reexamination FUNG ET AL.	
	Examiner Phallaka Kik	Art Unit 2825	Page 2 of 3

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,480,991	11-2002	Cho et al.	716/8
*	B	US-6,286,128	09-2001	Pileggi et al.	716/18
*	C	US-5,475,607	12-1995	Apte et al.	716/10
*	D	US-2005/0120319	06-2005	van Ginneken, Lukas P.P.P.	716/006
*	E	US-2003/0115566	06-2003	Teig, Steven	716/14
*	F	US-2002/0133799	09-2002	Alpert et al.	716/13
*	G	US-2002/0116685	08-2002	van Ginneken, Lukas P.P.P.	716/1
*	H	US-2001/0010090	07-2001	Boyle et al.	716/2
*	I	US-6,591,411	07-2003	Alpert et al.	716/13
*	J	US-6,557,145	04-2003	Boyle et al.	716/2
*	K	US-6,453,446	09-2002	van Ginneken, Lukas P. P. P.	716/3
*	L	US-6,006,024	12-1999	Guruswamy et al.	716/12
*	M	US-5,987,086	11-1999	Raman et al.	716/1

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited	Application/Control No. 10/774,883		Applicant(s)/Patent Under Reexamination FUNG ET AL.	
	Examiner Phallaka Kik		Art Unit 2825	Page 3 of 3

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2005/0050497	03-2005	Tetelbaum, Alexander	716/006
*	B	US-2005/0034091	02-2005	Harn, Ywh-Pyng	716/006
*	C	US-2004/0123261	06-2004	Alpert et al.	716/013
*	D	US-6,836,753	12-2004	Silve, Francois	703/2
*	E	US-6,408,427	06-2002	Cong et al.	716/13
*	F	US-6,904,585	06-2005	Brittain et al.	716/13
*	G	US-2003/0149954	08-2003	McElvain et al.	716/18
*	H	US-6,324,678	11-2001	Dangelo et al.	716/18
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.